

<b>Notice of References Cited</b>			Application No. 09/041,416	Applicant(s) Schuster et al.			
			Examiner Stephen R. Funk	Group Art Unit 2854	Page 1 of 1		
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\* A copy of this reference is not being furnished with this Office action.  
(See Manual of Patent Examining Procedure, Section 707.05(a).)